



30V DUAL N-CHANNEL ENHANCEMENT MODE MOSFET

Product Summary

V _{(BR)DSS}	R _{DS(on) max}	I _D T _A = +25°C
30V	$15m\Omega$ @ V_{GS} = $10V$	8.4A
	$18m\Omega$ @ $V_{GS} = 4.5V$	7.7A

Description

This new generation MOSFET has been designed to minimize the on-state resistance $(R_{DS(ON)})$ and yet maintain superior switching performance, making it ideal for high efficiency power management applications.

Applications

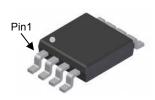
- DC-DC Converters
- Power Management Functions
- Backlighting

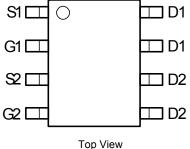
Features and Benefits

- Low Input Capacitance
- Low On-Resistance
- Fast Switching Speed
- Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)
- Qualified to AEC-Q101 Standards for High Reliability

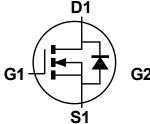
Mechanical Data

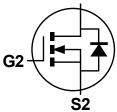
- Case: SO-8
- Case Material: Molded Plastic, "Green" Molding Compound.
 UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminal Connections: See Diagram
- Terminals: Finish Tin Finish annealed over Copper leadframe. Solderable per MIL-STD-202, Method 208 (3)
- Weight: 0.074 grams (approximate)





Pin Configuration





Equivalent Circuit

D2

Top View

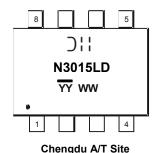
Ordering Information (Note 4)

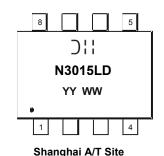
7			
	Part Number	Case	Packaging
	DMN3015LSD-13	SO-8	2,500/Tape & Reel

Notes:

- 1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS) & 2011/65/EU (RoHS 2) compliant.
- See http://www.diodes.com/quality/lead_free.html for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
- 3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.
- 4. For packaging details, go to our website at http://www.diodes.com/products/packages.html.

Marking Information





];; = Manufacturer's Marking
N3015LD = Product Type Marking Code
YYWW = Date Code Marking
YY or YY = Year (ex: 14 = 2014)
WW = Week (01 - 53)

 $\frac{\text{YY}}{\text{YY}}$ = Date Code Marking for SAT (Shanghai Assembly/ Test site) $\frac{\text{YY}}{\text{YY}}$ = Date Code Marking for CAT (Chengdu Assembly/ Test site)



Maximum Ratings (@T_A = +25°C, unless otherwise specified.)

Characteristic	Symbol	Value	Units		
Drain-Source Voltage	V_{DSS}	30	V		
Gate-Source Voltage			V_{GSS}	±20	V
Continuous Drain Compant (Nata C) V - 40V	Steady State	T _A = +25°C T _A = +70°C	Ι _D	8.4 6.8	А
Continuous Drain Current (Note 6) V _{GS} = 10V	t<10s	T _A = +25°C T _A = +70°C	Ι _D	11.0 9.0	А
Maximum Body Diode Forward Current (Note 6)	Is	2.5	Α		
Pulsed Drain Current (10µs pulse, duty cycle = 1%)	I _{DM}	80	Α		
Avalanche Current (Notes 7) L = 0.1mH	I _{AS}	22	Α		
Avalanche Energy (Notes 7) L = 0.1mH	E _{AS}	25	mJ		

Thermal Characteristics (@T_A = +25°C, unless otherwise specified.)

Characteristic	Symbol	Value	Units	
Total Power Dissipation (Note 5)	T _A = +25°C	D	1.2	W
Total Power Dissipation (Note 5)	T _A = +70°C	P_{D}	0.8	
Thermal Resistance, Junction to Ambient (Note 5)	Steady state	D	102	°C/W
Thermal Resistance, Junction to Ambient (Note 5)	t<10s	$R_{\theta JA}$	62	
Total Dower Dissination (Note 6)	$T_A = +25^{\circ}C$	D-	1.6	W
Total Power Dissipation (Note 6)	T _A = +70°C	P _D	1.0	
Thermal Resistance, Junction to Ambient (Note 6)	Steady state	В	78	
Thermal Resistance, Junction to Ambient (Note 6)	t<10s	$R_{\theta JA}$	47	°C/W
Thermal Resistance, Junction to Case (Note 6)	$R_{ heta JC}$	14.5		
Operating and Storage Temperature Range		T _J , T _{STG}	-55 to +150	°C

Electrical Characteristics (@TA = +25°C, unless otherwise specified.)

Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition
OFF CHARACTERISTICS (Note 8)						
Drain-Source Breakdown Voltage	BV _{DSS}	30		_	V	V _{GS} = 0V, I _D = 250μA
Zero Gate Voltage Drain Current	I _{DSS}	_	_	1	μΑ	V _{DS} = 30V, V _{GS} = 0V
Gate-Source Leakage	I _{GSS}	_	_	±100	nA	$V_{GS} = \pm 20V, V_{DS} = 0V$
ON CHARACTERISTICS (Note 8)						
Gate Threshold Voltage	V _{GS(TH)}	1.3	_	2.5	V	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$
Statio Drain Source On Registance		_	8	15		V _{GS} = 10V, I _D = 12A
Static Drain-Source On-Resistance	R _{DS(ON)}	_	12	18	mΩ	V _{GS} = 4.5V, I _D = 10A
Diode Forward Voltage	V _{SD}	_	0.7	1.0	V	V _{GS} = 0V, I _S = 1A
DYNAMIC CHARACTERISTICS (Note 9)						
Input Capacitance	C _{iss}	_	1415			V _{DS} = 15V, V _{GS} = 0V, f = 1.0MHz
Output Capacitance	Coss	_	119	_	pF	
Reverse Transfer Capacitance	C _{rss}	_	82	_		
Gate Resistance	R _G	_	2.6	3.2	Ω	V _{DS} = 0V, V _{GS} = 0V, f = 1.0MHz
Total Gate Charge (V _{GS} = 4.5V)	Qg	_	11.3	_		
Total Gate Charge (V _{GS} = 10V)	Q_g	_	25.1	_	~C	-45// - 40/
Gate-Source Charge	Qgs	_	3.5	_	nC	V _{DS} = 15V, I _D = 12A
Gate-Drain Charge	Q_{gd}	_	3.6	_		
Turn-On Delay Time	t _{D(on)}	_	4.8	_		
Turn-On Rise Time	t _r	_	16.5	_	0	V _{DD} = 15V, V _{GS} = 10V,
Turn-Off Delay Time	t _{D(off)}	_	26.1	_	nS	$R_L = 1.25\Omega$, $R_G = 3\Omega$,
Turn-Off Fall Time	tf	_	5.6	_		
Body Diode Reverse Recovery Time	t _{rr}	_	8.5	_	nS	I _S = 12A, dI/dt = 500A/μs
Body Diode Reverse Recovery Charge	Qrr	_	7.0	_	nC	I _S = 12A, dI/dt = 500A/µs

Notes: 5. Device mounted on FR-4 substrate PC board, 2oz copper, with minimum recommended pad layout.

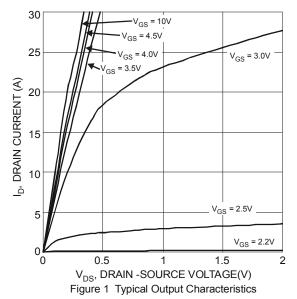
6. Device mounted on FR-4 substrate PC board, 2oz copper, with 1inch square copper plate.

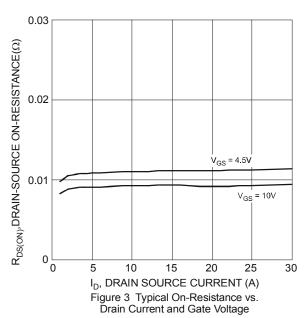
7. UIS in production with L = 0.1mH, starting $T_A = +25$ °C.

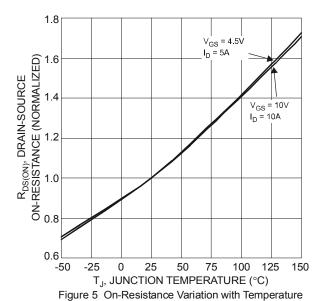
8. Short duration pulse test used to minimize self-heating effect.

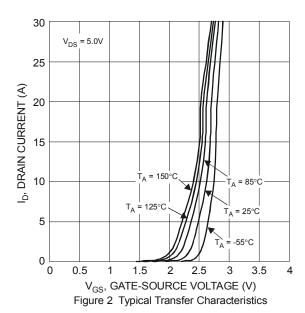
9. Guaranteed by design. Not subject to product testing.

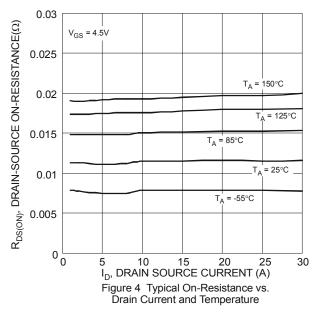












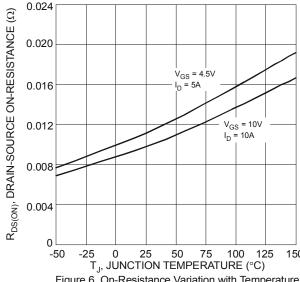


Figure 6 On-Resistance Variation with Temperature



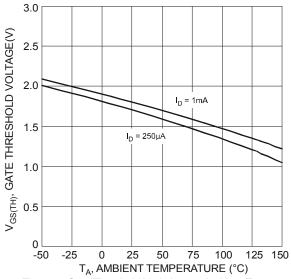
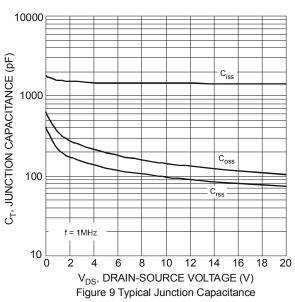
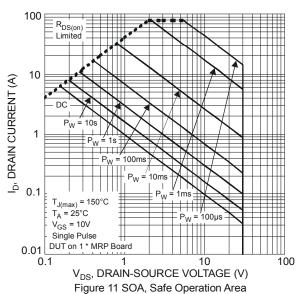
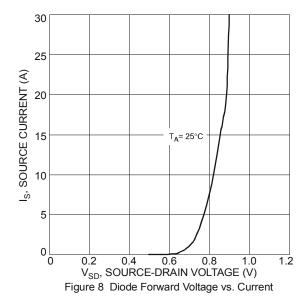
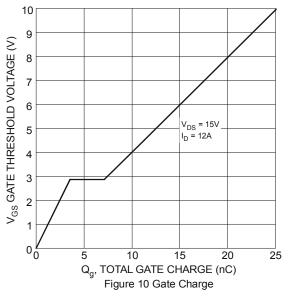


Figure 7 Gate Threshold Variation vs. Ambient Temperature

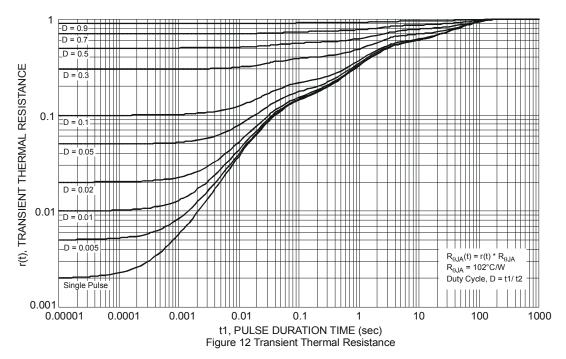






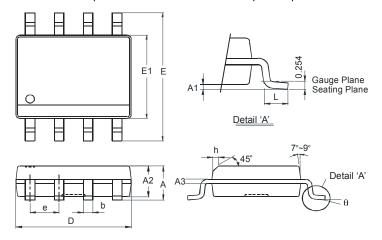






Package Outline Dimensions

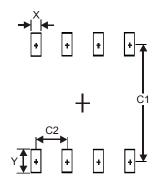
Please see AP02002 at http://www.diodes.com/datasheets/ap02002.pdf for latest version.



SO-8					
Dim	Min	Max			
Α	-	1.75			
A1	0.10	0.20			
A2	1.30	1.50			
Α3	0.15	0.25			
b	0.3	0.5			
D	4.85	4.95			
Е	5.90	6.10			
E1	3.85 3.95				
е	e 1.27 Typ				
h	1	0.35			
L	0.62	0.82			
θ	0°	8°			
All Dimensions in mm					

Suggested Pad Layout

Please see AP02001 at http://www.diodes.com/datasheets/ap02001.pdf for the latest version.



Dimensions	Value (in mm)
X	0.60
Υ	1.55
C1	5.4
C2	1.27



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